

## UT2319

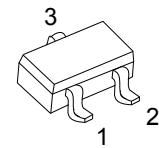
Power MOSFET

**-40V, -4.4A P-CHANNEL  
POWER MOSFET**

■ DESCRIPTION

The UTC UT2319 is a P-channel power MOSFET using UTC's advanced technology to provide the customers with high switching speed and a minimum on-state resistance, and it can also withstand high energy in the avalanche.

This UTC UT2319 is suitable for motor drivers, high-side switch and 12V board net, etc.

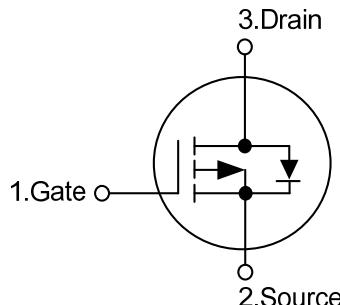


SOT-23  
(EIAJ SC-59)

■ FEATURES

- \*  $R_{DS(ON)} \leq 75 \text{ m}\Omega @ V_{GS}=-10V, I_D=-2.7A$
- \*  $R_{DS(ON)} \leq 100 \text{ m}\Omega @ V_{GS}=-10V, I_D=-2.4A$
- \* High Switching Speed

■ SYMBOL



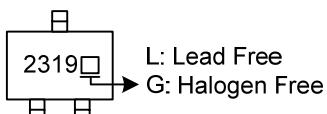
■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
UT2319L-AE3-R	UT2319G-AE3-R	SOT-23	G	S	D	Tape Reel

Note: Pin Assignment: G: Gate S: Source D: Drain

UT2319G-AE3-R	(1)Packing Type (2)Package Type (3)Green Package	(1) R: Tape Reel (2) AE3: SOT-23 (3) G: Halogen Free and Lead Free, L: Lead Free
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■ MARKING



■ ABSOLUTE MAXIMUM RATINGS ( $T_c=25^\circ\text{C}$ , unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		$V_{DSS}$	-40	V
Gate-Source Voltage		$V_{GSS}$	$\pm 20$	V
Drain Current	Continuous	$I_D$	-4.4	A
	Pulsed	$I_{DM}$	-20	A
Avalanche Energy	Single Pulsed (Note 3)	$E_{AS}$	17	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	1.7	V/ns
Power Dissipation		$P_D$	0.6	W
Junction Temperature		$T_J$	-55 ~ +150	$^\circ\text{C}$
Storage Temperature		$T_{STG}$	-55 ~ +150	$^\circ\text{C}$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3.  $L = 0.1\text{mH}$ ,  $I_{AS} = 18.5\text{A}$ ,  $V_{DD} = 20\text{V}$ ,  $R_G = 25 \Omega$ , Starting  $T_J = 25^\circ\text{C}$

4.  $I_{SD} \leq 4.4\text{A}$ ,  $di/dt \leq 200\text{A}/\mu\text{s}$ ,  $V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ\text{C}$

■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT
Junction to Ambient	$\theta_{JA}$	347	$^\circ\text{C/W}$
Junction to Case	$\theta_{JC}$	208	$^\circ\text{C/W}$

Note: Device mounted on FR-4 substrate  $P_C$  board, 2oz copper, with 1inch square copper plate.

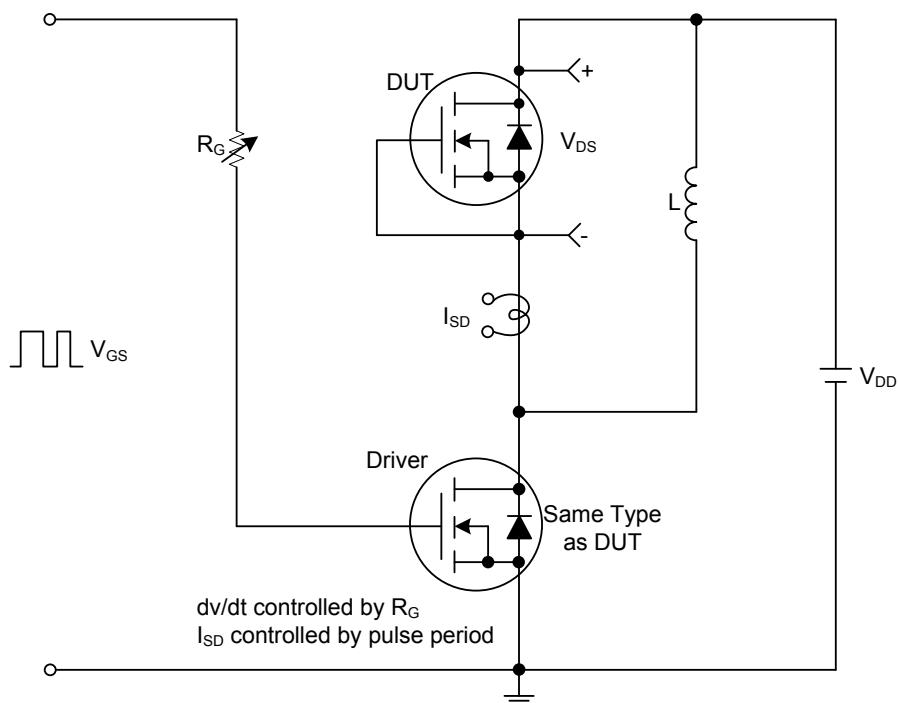
■ ELECTRICAL CHARACTERISTICS ( $T_J=25^\circ\text{C}$ , unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>OFF CHARACTERISTICS</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$I_D=-250\mu\text{A}, V_{GS}=0\text{V}$	-40			V
Drain-Source Leakage Current	$I_{\text{DSS}}$	$V_{DS}=-40\text{V}, V_{GS}=0\text{V}$		-1		$\mu\text{A}$
Gate- Source Leakage Current	Forward	$V_{GS}=+20\text{V}, V_{DS}=0\text{V}$			+100	nA
	Reverse	$V_{GS}=-20\text{V}, V_{DS}=0\text{V}$			-100	nA
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	$V_{GS(\text{TH})}$	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$	-1.0		-3.0	V
Static Drain-Source On-State Resistance (Note 1)	$R_{DS(\text{ON})}$	$V_{GS}=-10\text{V}, I_D=-2.7\text{A}$			75	$\text{m}\Omega$
		$V_{GS}=-4.5\text{V}, I_D=-2.4\text{A}$			100	$\text{m}\Omega$
<b>DYNAMIC PARAMETERS</b>						
Input Capacitance	$C_{\text{ISS}}$	$V_{DS}=-25\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		600		pF
Output Capacitance	$C_{\text{OSS}}$			105		pF
Reverse Transfer Capacitance	$C_{\text{RSS}}$			65		pF
<b>SWITCHING PARAMETERS</b>						
Total Gate Charge	$Q_G$	$V_{DS}=-32\text{V}, V_{GS}=-10\text{V}, I_D=-4.4\text{A}$ $I_G=-1\text{mA}$ (Note 1, 2)		15		nC
Gate to Source Charge	$Q_{GS}$			3.1		nC
Gate to Drain Charge	$Q_{GD}$			2.9		nC
Turn-ON Delay Time	$t_{D(\text{ON})}$	$V_{DS}=-20\text{V}, V_{GS}=-10\text{V}, I_D=-4.4\text{A},$ $R_G=3\Omega$ (Note 1, 2)		6		ns
Rise Time	$t_R$			16		ns
Turn-OFF Delay Time	$t_{D(\text{OFF})}$			22		ns
Fall-Time	$t_F$			17		ns
<b>SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS</b>						
Maximum Continuous Drain-Source Diode Forward Current	$I_S$				-4.4	A
Maximum Pulsed Drain-Source Diode Forward Current	$I_{SM}$				-20	A
Drain-Source Diode Forward Voltage (Note 1)	$V_{SD}$	$I_S=-4.4\text{A}, V_{GS}=0\text{V}$			1.4	V
Reverse Recovery Time (Note 1)	$t_{rr}$	$I_S=-4.4\text{A}, V_{GS}=0\text{V}$		44		ns
Reverse Recovery Charge	$Q_{rr}$	$dI/dt=-100\text{A}/\mu\text{s}$		28		nC

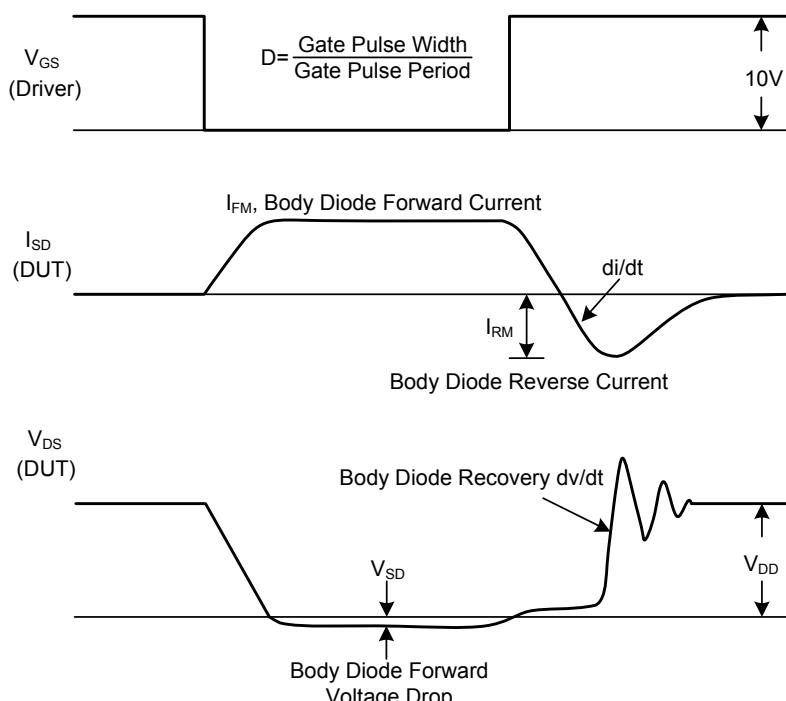
Notes: 1. Pulse Test : Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$ .

2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS



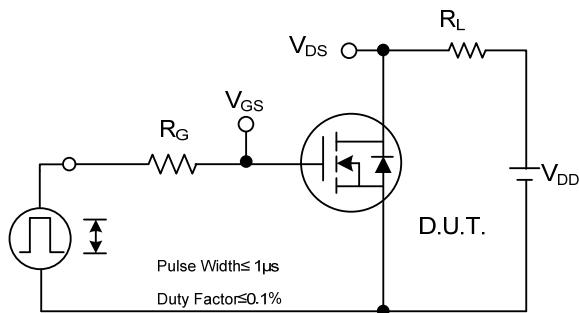
Peak Diode Recovery dv/dt Test Circuit



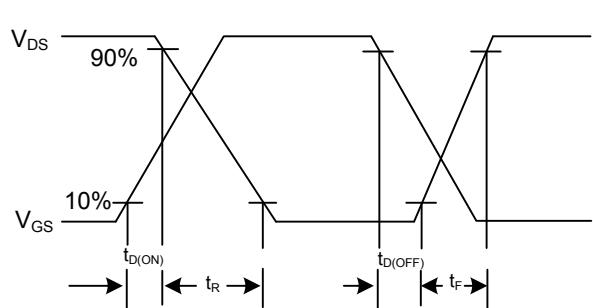
Peak Diode Recovery dv/dt Test Circuit and Waveforms

Peak Diode Recovery dv/dt Waveforms

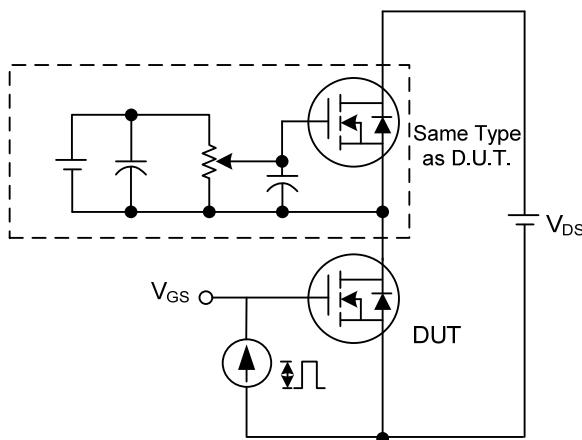
### ■ TEST CIRCUITS AND WAVEFORMS



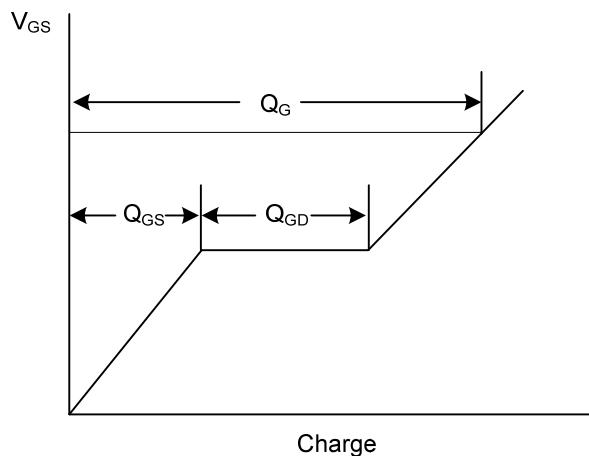
**Switching Test Circuit**



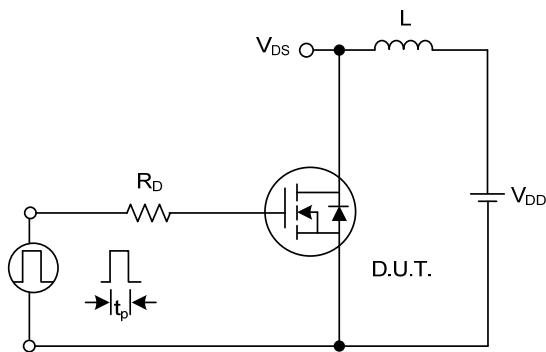
**Switching Waveforms**



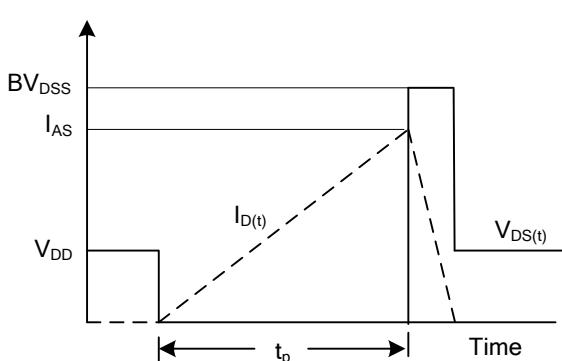
**Gate Charge Test Circuit**



**Gate Charge Waveform**

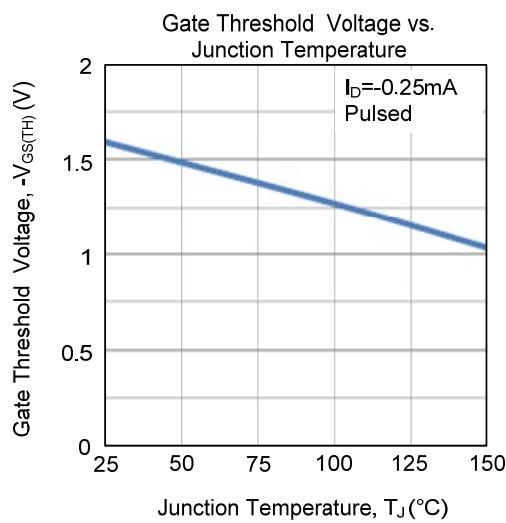
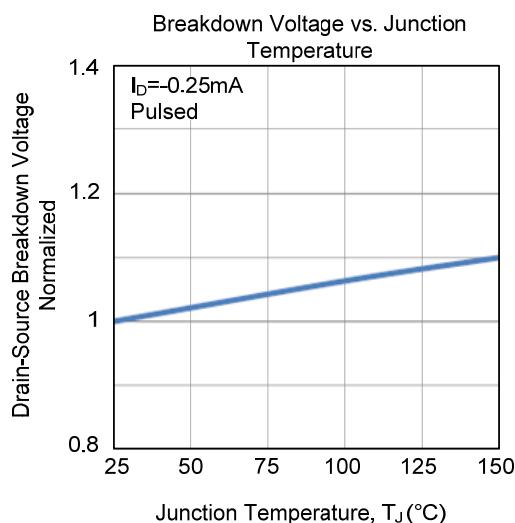
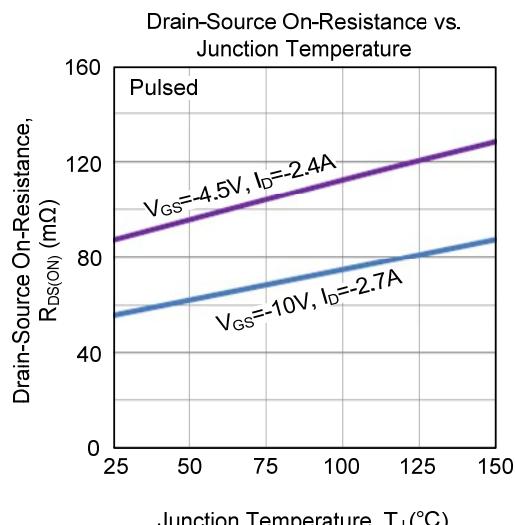
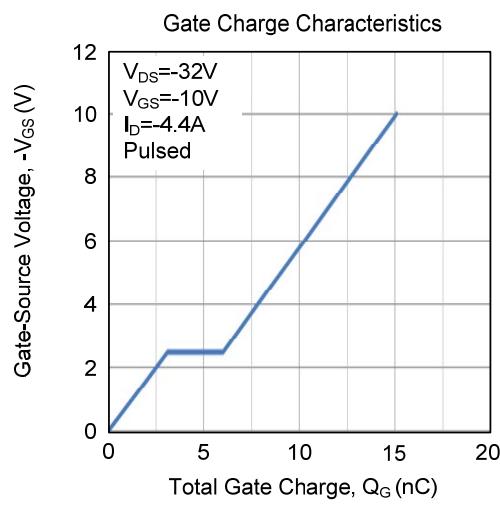
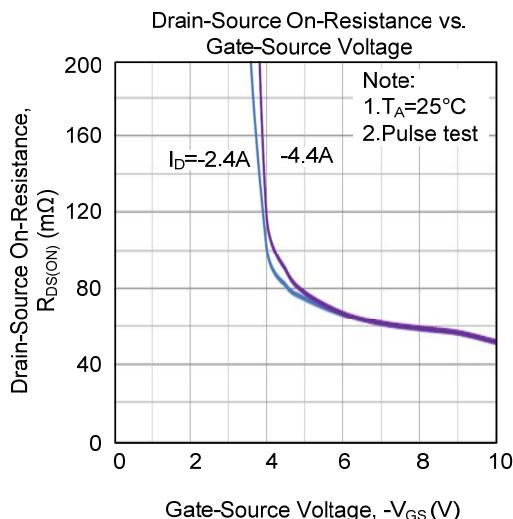
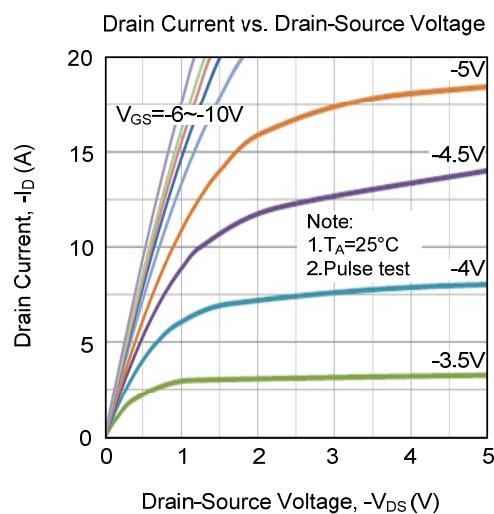


**Unclamped Inductive Switching Test Circuit**

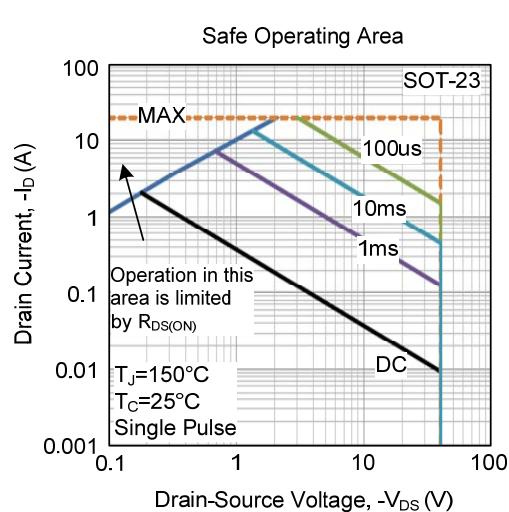
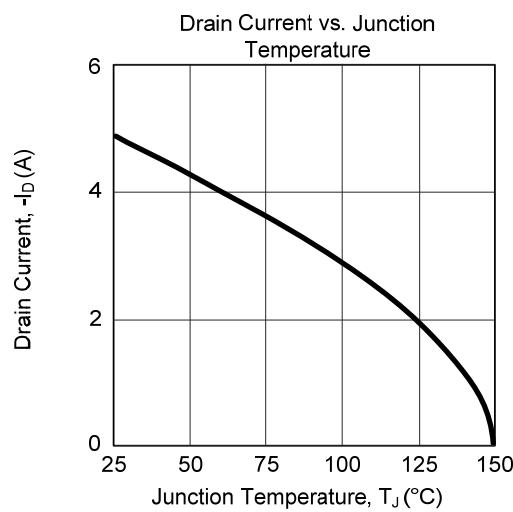
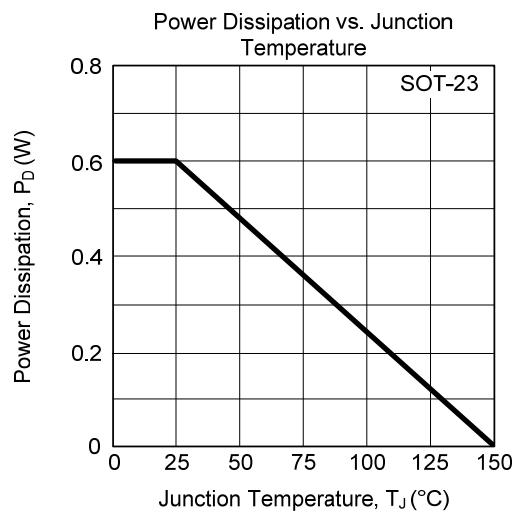
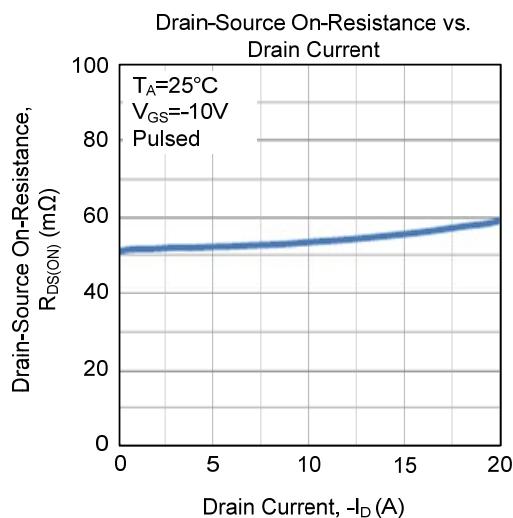
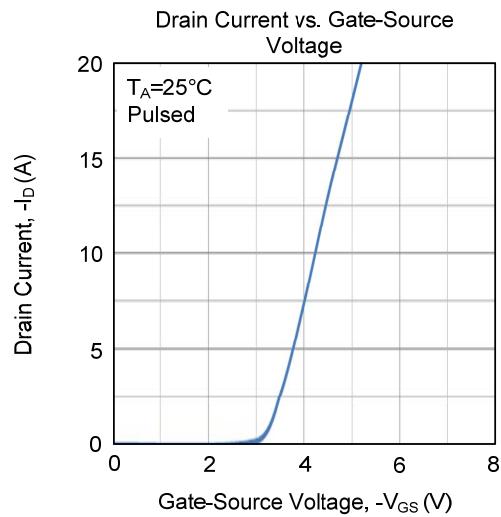
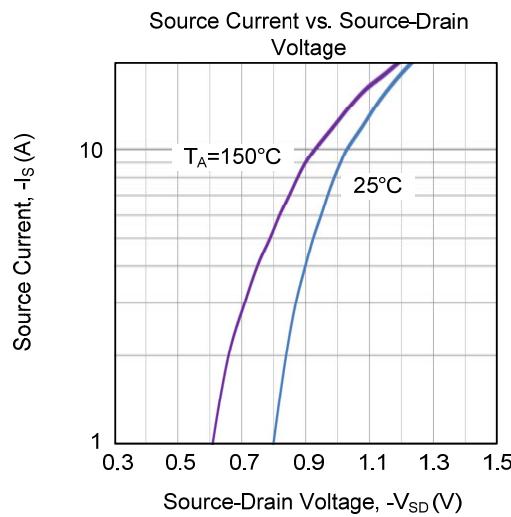


**Unclamped Inductive Switching Waveforms**

■ TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS (Cont.)



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